

An Introduction to Process Mining and Conformance Checking

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Collaborations with:

Mathilde Boltenhagen, Josep Carmona, Boudewijn van Dongen

June 6, 2019

Process Mining

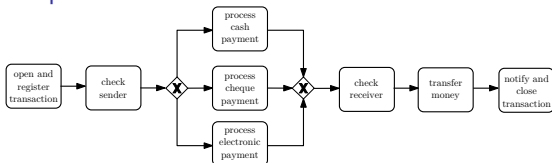
Process Mining

Discovery of process models from real process executions

Input: Event Logs Data recorded from process executions, e.g.:

- ▶ analyze usage of an e-commerce web site
- ▶ analyze medical processes in hospitals
- ▶ improve user interface
- ▶ detect deviant behavior

Output: Process Models



Process Mining

- ▶ At the interface between
 - ▶ Data science
 - ▶ Business Process Management
 - ▶ Machine learning
 - ▶ Formal models:
models used as representation for data
- ▶ Young and very active research domain
- ▶ New conference ICPM
 - ▶ 50 submissions...

Many (Industrial) Process Mining Tools

- ▶ Celonis
- ▶ Disco
- ▶ Minit
- ▶ ProM
- ▶ ...

Event Logs and Data Extraction¹

patient	activity	timestamp	doctor	age	cost
5781	make X-ray	23-1-2014:10.30	Dr. Jones	45	70.00
5541	blood test	23-1-2014:10.18	Dr. Scott	61	40.00
5833	blood test	23-1-2014:10.27	Dr. Scott	24	40.00
5781	blood test	23-1-2014:10.49	Dr. Scott	45	40.00
5781	CT scan	23-1-2014:11.10	Dr. Fox	45	1200.00
5833	surgery	23-1-2014:12.34	Dr. Scott	24	2300.00
5781	handle payment	23-1-2014:12.41	Carol Hope	45	0.00
5541	radiation therapy	23-1-2014:13.57	Dr. Jones	61	140.00
5541	radiation therapy	23-1-2014:13.08	Dr. Jones	61	140.00

¹Acknowledgements to Wil van der Aalst

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Event Logs and Data Extraction¹

patient	activity	timestamp
	make X-ray blood test CT scan handle payment	
	blood test radiation therapy radiation therapy	
	blood test surgery	

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Event Logs and Data Extraction¹

patient	activity	timestamp
	X B C P	
	B R R	
	B S	

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Event Logs and Data Extraction¹

patient	activity	timestamp
	X B C P	
	B R R	
	B S	

$\langle X, B, C, P \rangle$

$\langle B, R, R \rangle$

$\langle B, S \rangle$

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Process Discovery

Automatic construction of a model N from an event log L that represents a partial observation of a system S .

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 $\langle A, C, H, D, F, I \rangle$
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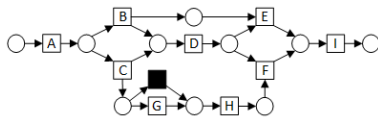
L

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 $\langle A, C, H, D, F, I \rangle$
 $\langle A, C, D, H, F, I \rangle$

L



N

One Process Discovery Technique: Inductive Mining

Credits: Wil van der Aalst

Process Discovery: Several Solutions

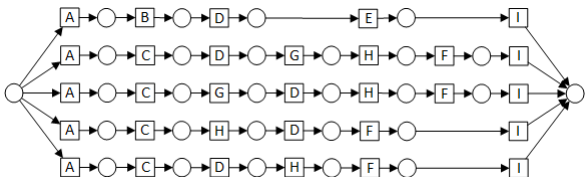
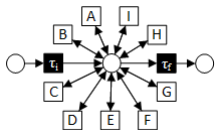
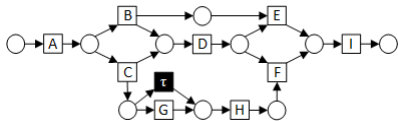
$\langle A, B, D, E, I \rangle$

$\langle A, C, D, G, H, F, I \rangle$

Log: $\langle A, C, G, D, H, F, I \rangle$

$\langle A, C, H, D, F, I \rangle$

$\langle A, C, D, H, F, I \rangle$



Conformance Checking

Define quality criteria to evaluate models:

- ▶ N fits L if $L \subseteq \mathcal{L}(N)$
- ▶ N is **precise** if $\mathcal{L}(N) \setminus L$ is small
- ▶ N **generalizes** L with respect to \mathcal{S} if $\mathcal{L}(N)$ contains some unobserved behavior in $\mathcal{L}(\mathcal{S}) \setminus L$
- ▶ **simplicity**...

Conformance Checking: Example

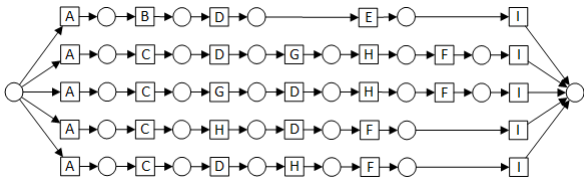
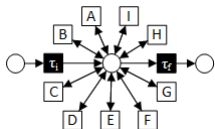
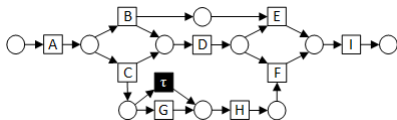
$\langle A, B, D, E, I \rangle$

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Log: $\langle A, C, G, D, H, F, I \rangle$

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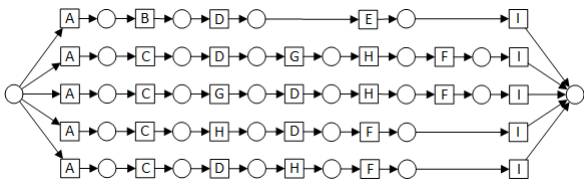
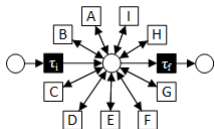
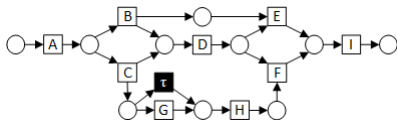
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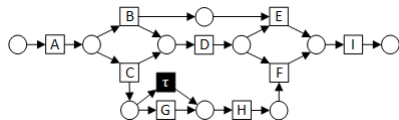
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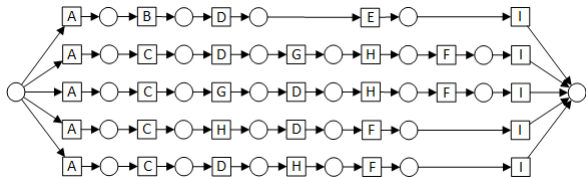
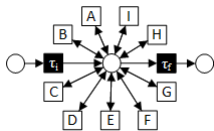
Log: $\langle A, C, G, D, H, F, I \rangle$

$\langle A, C, H, D, F, I \rangle$

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fitting
fairly precise
simple
generalizing



Conformance Checking: Example

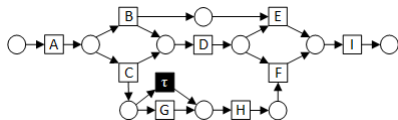
$\langle A, B, D, E, I \rangle$

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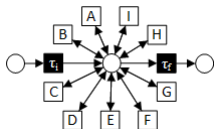
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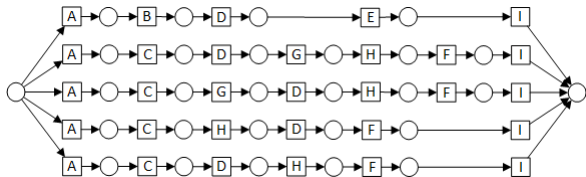
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fitting
fairly precise
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fitting
very imprecise
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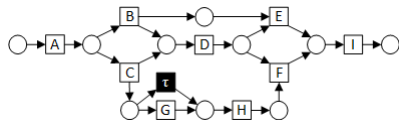
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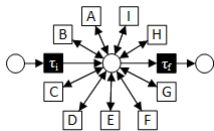
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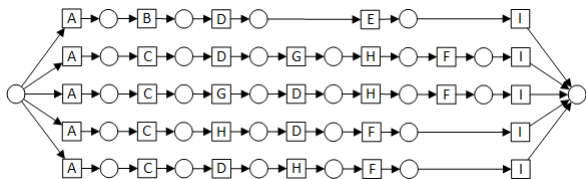
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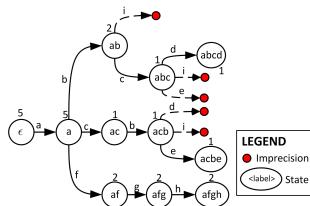
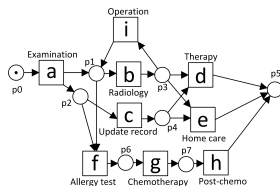
fitting
very imprecise
simple
generalizing



fitting
very precise
not simple
not generalizing

Measuring Precision – State of the Art

Log:
 $\langle a, b, c, d \rangle$
 $\langle a, c, b, e \rangle$
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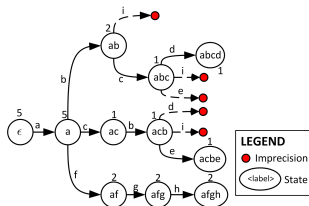
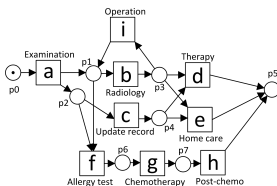


Alignment-based precision metrics [Adriansyah *et al.*]

- ▶ Build a representation $\mathcal{A}_{\Gamma(N,L)}$ of the part of the behaviour of the model which is covered by the log
- ▶ Count escaping points in $\mathcal{A}_{\Gamma(N,L)}$

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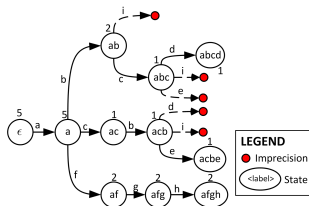
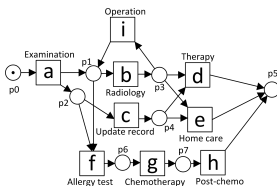
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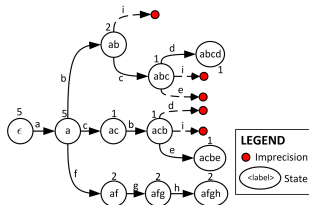
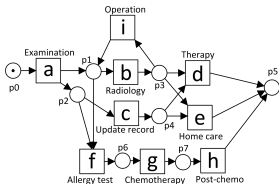
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Measuring Precision – State of the Art

Log:
 $\langle a, b, c, d \rangle$
 $\langle a, c, b, e \rangle$
 $\langle a, f, g, h \rangle$
 $\langle a, b, i, b, c, d \rangle$



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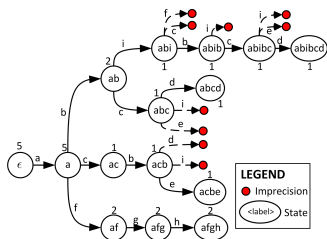
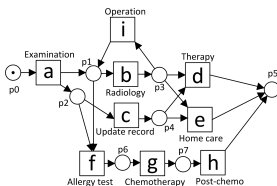
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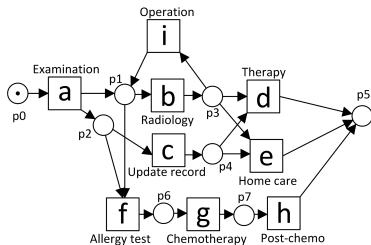
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Alignments

Alignment

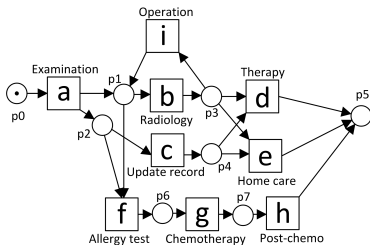
Given a trace σ and a model N ,
an alignment is a full run u of N which minimizes its distance to σ .



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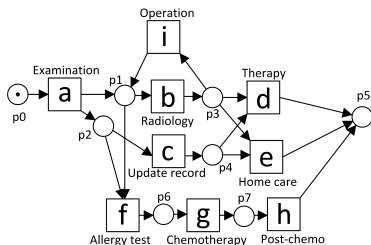
Example:

For trace $\langle a, f, c, h \rangle$,
best alignment: $\langle a, f, g, h \rangle$

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Alignment

Given a trace σ and a model N ,
an alignment is a full run u of N which minimizes its distance to σ .



Example:

For trace $\langle a, f, c, h \rangle$,
best alignment: $\langle a, f, g, h \rangle$

Important notion in process mining:

- ▶ for computing fitness and precision,
- ▶ for detecting deviations,
- ▶ for model enhancement techniques.

Anti-alignments and Precision

Anti-alignments – Motivation

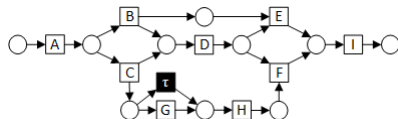
Log L :

$\langle A, C, D, G, H, F, I \rangle$

$\langle A, C, G, D, H, F, I \rangle$

$\langle A, C, D, H, F, I \rangle$

$\langle A, C, H, D, F, I \rangle$



Motivation

In order to measure precision, find the run of N which is most **misaligned** with the log L .

Anti-alignments – Motivation

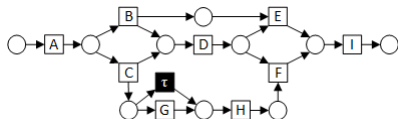
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Motivation

In order to measure precision, find the run of N which is most **misaligned** with the log L .

Here: $\langle A, B, D, E, I \rangle$

Anti-alignments

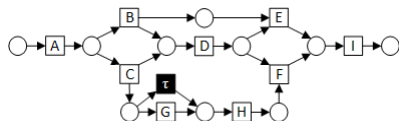
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- ▶ $L \subset \Sigma^*$: a log (set of traces) of an observed system
- ▶ N : a (labeled) Petri net model (constructed by process discovery)

Definition (Anti-alignment)

An (n, m) -anti-alignment of a model N w.r.t. a log L is a run $\gamma \in \mathcal{L}(N)$ such that

- ▶ $|\gamma| \leq n$ and
- ▶ for every $\sigma \in L$, $dist(\gamma, \sigma) \geq m$.

Which distance *dist*?

Definition (Levenshtein's edit distance $dist(\gamma, \sigma)$)

Number of letter replacements/deletions/insertions needed to edit γ to σ .

▶ Example: $dist_{\text{Levenshtein}}(\langle ababababab \rangle, \langle bababababa \rangle) = 2$

Definition (Hamming distance)

For two traces $\gamma = \gamma_1 \dots \gamma_n$ and $\sigma = \sigma_1 \dots \sigma_n$, of same length n , define $dist(\gamma, \sigma) \stackrel{\text{def}}{=} |\{i \in \{1 \dots n\} \mid \gamma_i \neq \sigma_i\}|$.

Pad when different lengths

▶ Example: $dist_{\text{Hamming}}(\langle ababababab \rangle, \langle bababababa \rangle) = 10$

Anti-alignments: Example

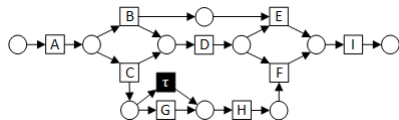
Log L :

$\langle A, C, D, G, H, F, I \rangle$

$\langle A, C, G, D, H, F, I \rangle$

$\langle A, C, D, H, F, I \rangle$

$\langle A, C, H, D, F, I \rangle$



$(5, 3)$ -anti-alignment $\langle A, B, D, E, I \rangle$

NP-completeness

Lemma

*The problem of existence of (n, m) -anti-alignment is NP-complete.
(with n and m represented in unary.)*

Proof.

The problem is clearly in NP: checking that a run γ is a (n, m) -anti-alignment for a net N and a log L takes polynomial time.

For NP-hardness, reduction from the problem of reachability of a marking M in a safe acyclic Petri net N , known to be NP-complete ^a. □

^aCheng, A., Esparza, J., Palsberg, J.: Complexity results for safe nets. Theor. Comput. Sci. 147(1&2) (1995) 117–136

Anti-alignments to Measure Precision

- ▶ $L \subset \Sigma^*$: a log (set of traces) of an observed system
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Anti-alignment-based precision metrics

$$P^n(N, L) = 1 - \frac{\max^n(N, L)}{n}$$

with

- ▶ n : (in the order of) the maximal length for a trace in the log
- ▶ $\max^n(N, L)$: the largest m for which there exists a (n, m) -anti-alignment

Clearly, $\max^n(N, L) \in [0 \dots n]$ which implies $P^n(N, L) \in [0 \dots 1]$.

Anti-alignments to Measure Precision – Exercise

Sort the models by decreasing precision.

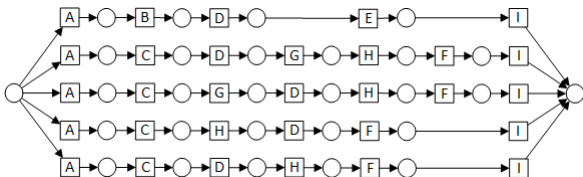
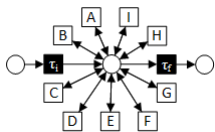
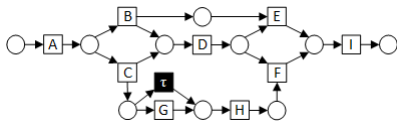
$\langle A, B, D, E, I \rangle$

$\langle A, C, D, G, H, F, I \rangle$

Log: $\langle A, C, G, D, H, F, I \rangle$

$\langle A, C, H, D, F, I \rangle$

$\langle A, C, D, H, F, I \rangle$



Anti-alignments to Measure Precision – Exercise

Sort the models by decreasing precision.

For each model, find the best anti-alignment of length ≤ 7 .

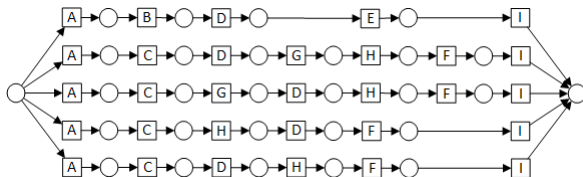
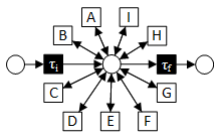
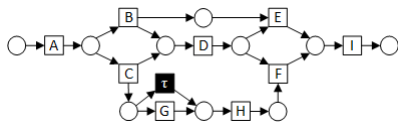
$\langle A, B, D, E, I \rangle$

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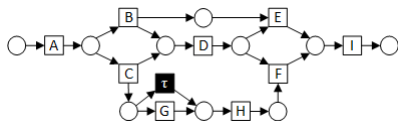
$\langle A, B, D, E, I \rangle$

$\langle A, C, D, G, H, F, I \rangle$

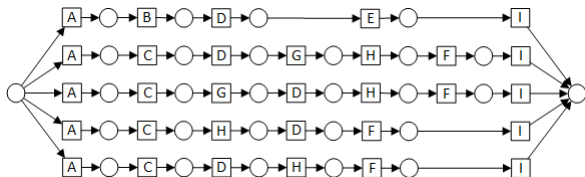
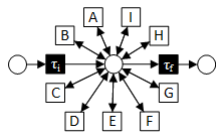
Log: $\langle A, C, G, D, H, F, I \rangle$

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$\langle A, C, D, H, F, I \rangle$



Anti-alignment $\langle A, C, G, H, D, F, I \rangle$
 $P^7(N_1, L) = 0.857$



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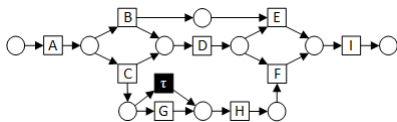
$\langle A, B, D, E, I \rangle$

$\langle A, C, D, G, H, F, I \rangle$

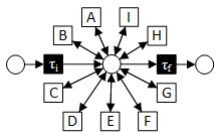
Log: $\langle A, C, G, D, H, F, I \rangle$

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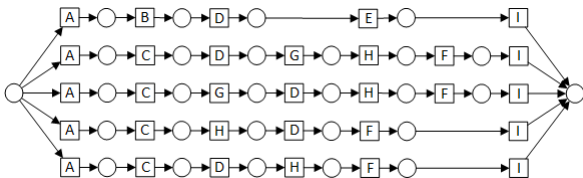
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 $P^7(N_1, L) = 0.857$



Anti-alignment
 $\langle I, I, I, A, A, A, A \rangle$
 $P^7(N_2, L) = 0$



Anti-alignments to Measure Precision – Exercise

Sort the models by decreasing precision.

For each model, find the best anti-alignment of length ≤ 7 .

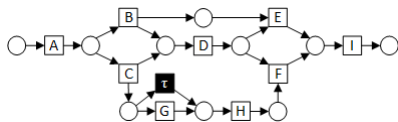
$\langle A, B, D, E, I \rangle$

$\langle A, C, D, G, H, F, I \rangle$

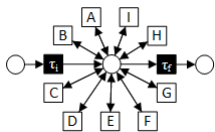
Log: $\langle A, C, G, D, H, F, I \rangle$

$\langle A, C, H, D, F, I \rangle$

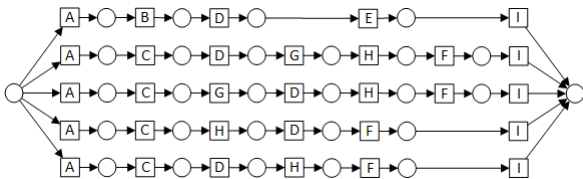
$\langle A, C, D, H, F, I \rangle$



Anti-alignment $\langle A, C, G, H, D, F, I \rangle$
 $P^7(N_1, L) = 0.857$



Anti-alignment
 $\langle I, I, I, A, A, A, A \rangle$
 $P^7(N_2, L) = 0$



No $(7, 1)$ -anti-alignment
 $P^7(N_3, L) = 1$

Handling Models with Loops

A model with an executable loop has

- ▶ arbitrary long runs
- ▶ runs arbitrary far from any finite log

Drop the bound n , but penalize long runs when looking for the optimal.

$$P^\epsilon(N, L) \stackrel{\text{def}}{=} 1 - \sup_{\gamma \in \mathcal{L}(N)} \frac{\text{dist}(\gamma, L)}{(1 + \epsilon)^{|\gamma|}}$$

with some $\epsilon \geq 0$ which is a parameter of this definition.

Monotonicity w.r.t. New Observations

Observing a new trace which happens to be already a run of the model, can only increase the precision measure.

Theorem

For every N, L and for every $\sigma \in \mathcal{L}(N)$,

$$P^n(N, L \cup \{\sigma\}) \geq P^n(N, L)$$

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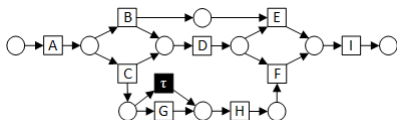
Hint: every (n, m) -anti-alignment for $(N, L \cup \{\sigma\})$ is also a (n, m) -anti-alignment for (N, L) .

Example

Log L :

$\langle A, C, D, G, H, F, I \rangle$

$\langle A, C, G, D, H, F, I \rangle$



Best anti-alignment

$\langle A, B, D, E, I \rangle$

$\max^7(N, L)$

4

$P^7(N, L)$

$\frac{3}{7}$

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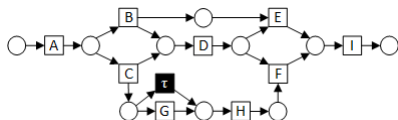
Example

Log L :

$\langle A, C, D, G, H, F, I \rangle$

$\langle A, C, G, D, H, F, I \rangle$

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Best anti-alignment $\max^7(N, L) \quad P^7(N, L)$

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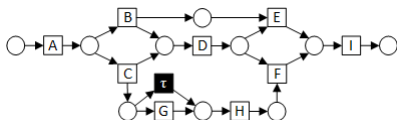
Example

Log L :

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$\langle A, C, G, D, H, F, I \rangle$

$\langle A, B, D, E, I \rangle$



Best anti-alignment

$\langle A, C, H, D, F, I \rangle$

$\max^7(N, L)$

2

$P^7(N, L)$

$\frac{5}{7}$

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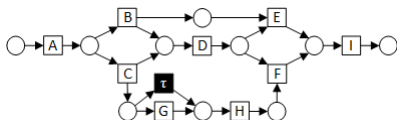
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Best anti-alignment $\max^7(N, L) \quad P^7(N, L)$

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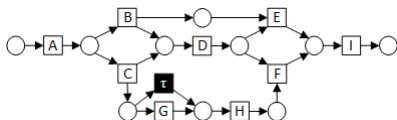
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$\langle A, C, G, D, H, F, I \rangle$

$\langle A, B, D, E, I \rangle$

$\langle A, C, D, H, F, I \rangle$



Best anti-alignment $\max^7(N, L)$ $P^7(N, L)$
 $\langle A, C, H, D, F, I \rangle$ 2 $\frac{5}{7}$

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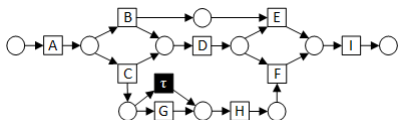
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$\langle A, C, G, D, H, F, I \rangle$

$\langle A, B, D, E, I \rangle$

$\langle A, C, D, H, F, I \rangle$

$\langle A, C, H, D, F, I \rangle$



Best anti-alignment $\max^7(N, L) \quad P^7(N, L)$

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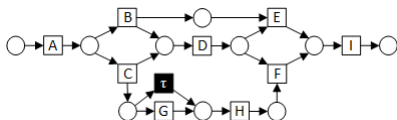
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$\langle A, B, D, E, I \rangle$

$\langle A, C, D, H, F, I \rangle$

$\langle A, C, H, D, F, I \rangle$



Best anti-alignment	$\max^7(N, L)$	$P^7(N, L)$
$\langle A, C, G, H, D, F, I \rangle$	1	$\frac{6}{7}$

Monotonicity w.r.t. Model Language

Theorem

Given two models N_1 and N_2 , if $\mathcal{L}(N_1) \subseteq \mathcal{L}(N_2)$, then N_1 is more precise than N_2 .

$$\mathcal{L}(N_1) \subseteq \mathcal{L}(N_2) \implies P^n(N_1, L) \geq P^n(N_2, L)$$

Implementation

Formula $\Phi_m^n(N, L)$ states that γ is a (n, m) -anti-alignment:

- ▶ $\gamma = \lambda(t_1) \dots \lambda(t_n) \in \mathcal{L}(N)$, and
- ▶ for every $\sigma \in L$, $dist(\gamma, \sigma) \geq m$.

Encoding in SAT

$\Phi_m^n(N, L)$ is coded using the following Boolean variables:

- ▶ $\tau_{i,t}$ for $i = 1 \dots n$, $t \in T$ means that transition $t_i = t$.
- ▶ $m_{i,p}$ for $i = 0 \dots n$, $p \in P$ means that place p is marked in marking M_i (safe Petri nets: Boolean variables)
- ▶ $\delta_{i,j,\sigma}$ to encode the distances $dist(\gamma, \sigma)$.

Total size for the SAT encoding of the formula $\Phi_m^n(N, L)$:

$$O(n \times |T| \times (|N| + m^2 \times |L|))$$

Encoding in SAT (1) $\gamma = \lambda(t_1) \dots \lambda(t_n) \in \mathcal{L}(N)$

- ▶ Initial marking:

$$\left(\bigwedge_{p \in M_0} m_{0,p} \right) \wedge \left(\bigwedge_{p \in P \setminus M_0} \neg m_{0,p} \right)$$

- ▶ One and only one t_i for each i :

$$\bigwedge_{i=1}^n \bigvee_{t \in T} (\tau_{i,t} \wedge \bigwedge_{t' \in T} \neg \tau_{i,t'})$$

- ▶ The transitions are enabled when they fire:

$$\bigwedge_{i=1}^n \bigwedge_{t \in T} (\tau_{i,t} \implies \bigwedge_{p \in \bullet_t} m_{i-1,p})$$

- ▶ Token game (for safe Petri nets):

$$\bigwedge_{i=1}^n \bigwedge_{t \in T} \bigwedge_{p \in t^\bullet} (\tau_{i,t} \implies m_{i,p})$$

$$\bigwedge_{i=1}^n \bigwedge_{t \in T} \bigwedge_{p \in \bullet_t \setminus t^\bullet} (\tau_{i,t} \implies \neg m_{i,p})$$

$$\bigwedge_{i=1}^n \bigwedge_{t \in T} \bigwedge_{p \in P, p \notin \bullet_t, p \notin t^\bullet} (\tau_{i,t} \implies (m_{i,p} \iff m_{i-1,p}))$$

Encoding in SAT (2)

$$\mathit{dist}(\gamma, \sigma) \geq m$$

Encoding in SAT (2)

- ▶ For Hamming distance: **easy**

$$\mathit{dist}(\gamma, \sigma) \geq m$$

Encoding in SAT (2)

$$\text{dist}(\gamma, \sigma) \geq m$$

- ▶ For Hamming distance: easy
- ▶ For Levenshtein's distance:
Use same relations as the classical algorithm:

$$\text{dist}(\langle u_1, \dots, u_i \rangle, \epsilon) = i$$

$$\text{dist}(\epsilon, \langle v_1, \dots, v_j \rangle) = j$$

$$\text{dist}(\langle u_1, \dots, u_{i+1} \rangle, \langle v_1, \dots, v_{j+1} \rangle) =$$

$$\begin{cases} \text{dist}(\langle u_1, \dots, u_i \rangle, \langle v_1, \dots, v_j \rangle) & \text{if } u_{i+1} = v_{j+1} \\ 1 + \min(\text{dist}(\langle u_1, \dots, u_{i+1} \rangle, \langle v_1, \dots, v_j \rangle), & \text{if } u_{i+1} \neq v_{j+1} \\ \text{dist}(\langle u_1, \dots, u_i \rangle, \langle v_1, \dots, v_{j+1} \rangle)) & \end{cases}$$

Encoding as SAT formula using variables $\delta_{i,j,d}$

$\delta_{i,j,d} = \text{true}$ means $\text{dist}(\langle u_1 \dots u_i \rangle, \langle v_1 \dots v_j \rangle) \geq d$.

$$\delta_{0,0,0} \wedge \bigwedge_{d>0} \neg \delta_{0,0,d} \tag{1}$$

$$\bigwedge_d \bigwedge_{i=0}^n (\delta_{i+1,0,d+1} \Leftrightarrow \delta_{i,0,d}) \tag{2}$$

$$\bigwedge_d \bigwedge_{j=0}^n (\delta_{0,j+1,d+1} \Leftrightarrow \delta_{0,j,d}) \tag{3}$$

$$\bigwedge_d \bigwedge_{i,j \text{ s.t. } u_{i+1}=v_{j+1}} \delta_{i+1,j+1,d} \Leftrightarrow \delta_{i,j,d} \tag{4}$$

$$\bigwedge_d \bigwedge_{i,j \text{ s.t. } u_{i+1} \neq v_{j+1}} \delta_{i+1,j+1,d+1} \Leftrightarrow (\delta_{i+1,j,d} \wedge \delta_{i,j+1,d}) \tag{5}$$

Experiments: Alignments (showing averages)

Model			$ L $	Size of run	Maximal number of editions	Formula construction time (sec)	Total execution time (sec)
Reference	$ T $	$ P $					
Fig. 2	8	7	100	7	5	0.239	0.349
M8 of [25]	15	17	100	PRE: 20	LIM:10	10.139	15.530
M1 of [25]	40	39	100	PRE: 7	LIM:10	4.924	7.16
Loan [10]	15	16	100	PRE: 19	LIM: 10	14.047	20.915

Experiments: Anti-alignments

Model			$ L $	Size of run	Maximal number of editions	Formula construction time (sec)	Total execution time (sec)
Reference	$ T $	$ P $					
Fig. 2	8	7	10	8	LIM: 10	13.802	21.502
			100	8	LIM: 10	137.213	243.842
M8 of [25]	15	17	10	18	LIM:10	103.812	148.271
			100	PRE: 10	LIM: 10	343.529	496.733
M1 of [25]	40	39	10	39	LIM:10	1337.806	2069.505
			100	PRE:13	LIM:5	680.556	995.361
Loan [10]	15	16	10	PRE: 19	LIM: 10	140.840	203.257
			100	PRE:19	LIM: 10	1526.048	2185.785

Experiments: Anti-alignments (Hamming distance)

<i>benchmark</i>	$ P $	$ T $	$ L $	$ A_L $	n	m	$\Phi_m^n(N, L)$	$\min_m(N, L)$	$\max^n(N, L)$
prAm6	347	363	761	272	41	1	✓	3	39
						5	✓	7	
					21	1	✓	3	
						5	✓	7	
			1200	363	41	1	✓	4	19
						5	✓	8	
21	5	1	✓	4	15				
		5	✓	8					
BankTransfer	121	114	989	101	51	1	✓	8	32
						10	✓	17	
					21	1	✓	8	
						10	✓	17	
			2000	113	51	1	✓	15	16
						10	✓	37	
21	10	1	✓	15	5				
		10	✗	37					

Experiments: Multi-alignments

Model			$ L $	Size of run	Maximal number of editions	Formula construction time (sec)	Total execution time (sec)
Reference	$ T $	$ P $					
Fig. 2	8	7	10	8	7	10.101	15.362
			100	8	7	99.602	200.569
M8 of [25]	15	17	10	18	LIM:6	252.471	414.174
			100	PRE:15	LIM:6	516.391	741.162
M1 of [25]	40	39	10	PRE: 13	LIM:10	115.706	172.500
			100	PRE: 13	LIM: 5	681.95	1066.94
Loan [10]	15	16	10	PRE: 19	15	252.572	373.683
			100	PRE: 9	LIM:10	359.982	508.542

Conclusion

Anti-alignment

- ▶ Run of the model which maximizes its distance to the observed traces
- ▶ New metric for **precision** in process mining
 - ▶ monotonic w.r.t. new observations

Implementations

- ▶ DARKSIDER (using SAT encoding)
`www.lsv.ens-cachan.fr/~chatain/darksider`
- ▶ Also available in ProM
`www.promtools.org`

SAT-based approach for conformance checking

- ▶ Very flexible
- ▶ Good for prototyping
- ▶ Efficiency depends a lot on precise problem and encoding

Thank you!